Search Notes				
	: 10151 10001 Offic 20101 10111 1201 1001			
	FRIN 1980 BIN AND IN 1811 1811 1811			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/975,087	DEML ET AL.	
Examiner	Art Unit	
Nauven Nao	2663	

SEARCHED				
Class	Subclass	Date	Examiner	
370	465	10/14/2005	NHN	
370	466	10/14/2005	NHN	
370	401	10/14/2005	NHN	
370	395.5	10/14/2005	NHN	
370	395.1	10/14/2005	NHN	
370	395.52	10/14/2005	NHN	
370	392	10/14/2005	NHN	
370	474	10/14/2005	NHN	
370	356	10/14/2005	NHN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	466	10/14/2005	NHN	
370	392	10/14/2005	NHN	
370	467	10/14/2005	NHN	
370/3	95.52	10/14/2005	NHN	

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
Consulted SPE Ricky Ngo	10/14/2005	NHN
Consulted Junior Examiner Christopher Heinrichs	10/14/2005	NHN
Text Search (EAST) updated see atached	10/14/2005	NHN
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